Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/540,567	Reexamination KAWAKATSU, HI	DEKI
Examiner	Art Unit	
J M. SAINT SURIN	2856	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,330,824	12-2001	Erie et al.	73/105
*	В	US-5,633,455	05-1997	Quate, Calvin F.	73/105
*	O	US-6,006,593	12-1999	Yamanaka, Kazushi	73/105
*	D	US-3,577,101	05-1971	Pege, Lotar	331/154
*	Е	US-6,438,243	08-2002	Ikeuchi et al.	381/191
*	F	US-6,507,197	01-2003	Itoh et al.	324/456
*	ø	US-6,605,941	08-2003	Abe, Masayuki	324/244
*	Ξ	US-6,227,054	05-2001	Ando et al.	73/651
*	-	US-7,309,863	12-2007	Kawakatsu, Hideki	250/306
*	٦	US-2002/0021450	02-2002	Aoki, Toshihiko	356/499
*	К	US-6,838,688	01-2005	Aoki, Toshihiko	250/559.29
*	L	US-4,263,810	04-1981	Chiu, Hong-Yee	73/800
*	м	US-7,220,962	05-2007	Kawakatsu, Hideki	250/306

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*	NONFAIENI DOCUMENIS				
<u> </u>		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	v				
	w				
	×				

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.